

# FTD2008

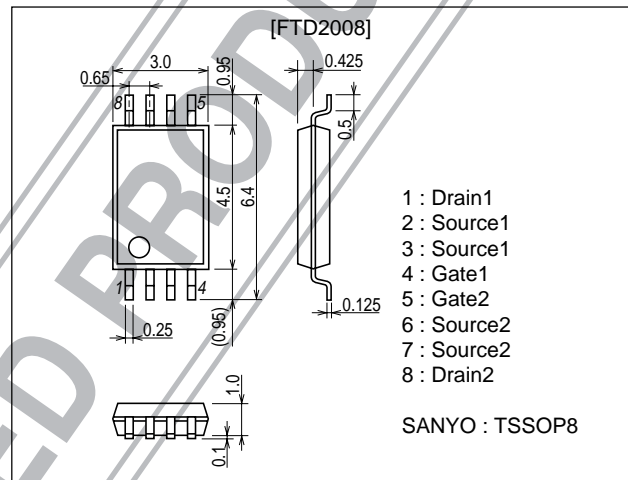
N-Channel Silicon MOSFET

## DC / DC Converter Applications

### Features

- Low ON-resistance.
- 4V drive.
- Mounting height 1.1mm.
- Composite type, facilitating high-density mounting.

### Package Dimensions

unit : mm  
2155A

### Specifications

#### Absolute Maximum Ratings at Ta=25°C

| Parameter                   | Symbol           | Conditions  | Ratings     | Unit |
|-----------------------------|------------------|---|-------------|------|
| Drain-to-Source Voltage     | V <sub>DSS</sub> |   | 60          | V    |
| Gate-to-Source Voltage      | V <sub>GSS</sub> |   | ±20         | V    |
| Drain Current (DC)          | I <sub>D</sub>   |   | 1.5         | A    |
| Drain Current (Pulse)       | I <sub>DP</sub>  | PW≤10μs, duty cycle≤1%  | 6           | A    |
| Allowable Power Dissipation | P <sub>D</sub>   | Mounted on a ceramic board (1000mm <sup>2</sup> ×0.8mm) 1unit | 0.8         | W    |
| Total Dissipation           | P <sub>T</sub>   | Mounted on a ceramic board (1000mm <sup>2</sup> ×0.8mm)       | 1.0         | W    |
| Channel Temperature         | T <sub>ch</sub>  |   | 150         | °C   |
| Storage Temperature         | T <sub>stg</sub> |   | -55 to +150 | °C   |

#### Electrical Characteristics at Ta=25°C

| Parameter                         | Symbol               | Conditions                                 | Ratings |     |     | Unit |
|-----------------------------------|----------------------|--|---------|-----|-----|------|
|                                   |                      |  | min     | typ | max |      |
| Drain-to-Source Breakdown Voltage | V <sub>(BR)DSS</sub> | I <sub>D</sub> =1mA, V <sub>GS</sub> =0    | 60      |     |     | V    |
| Zero-Gate Voltage Drain Current   | I <sub>DSS</sub>     | V <sub>DS</sub> =60V, V <sub>GS</sub> =0   |         |     | 10  | μA   |
| Gate-to-Source Leakage Current    | I <sub>GSS</sub>     | V <sub>GS</sub> =±16V, V <sub>DS</sub> =0  |         |     | ±10 | μA   |
| Cutoff Voltage                    | V <sub>GS(off)</sub> | V <sub>DS</sub> =10V, I <sub>D</sub> =1mA  | 1.0     |     | 2.4 | V    |
| Forward Transfer Admittance       | y <sub>fs</sub>      | V <sub>DS</sub> =10V, I <sub>D</sub> =0.8A | 1.4     | 2.0 |     | S    |

Marking : D2008

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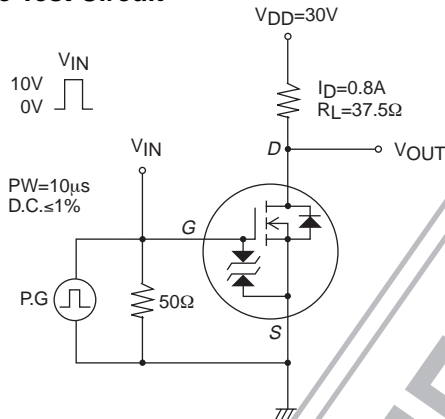
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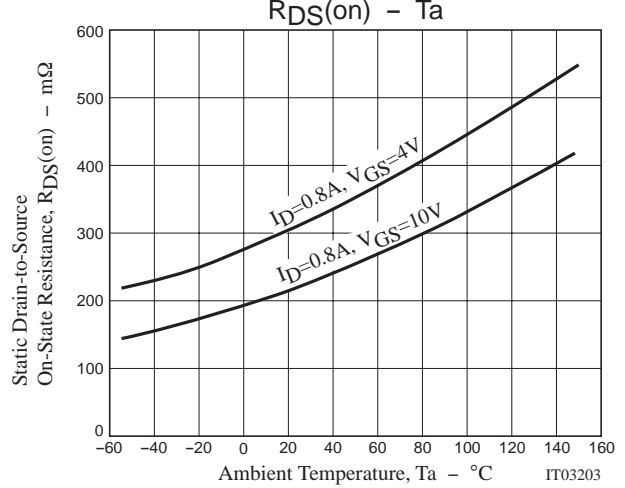
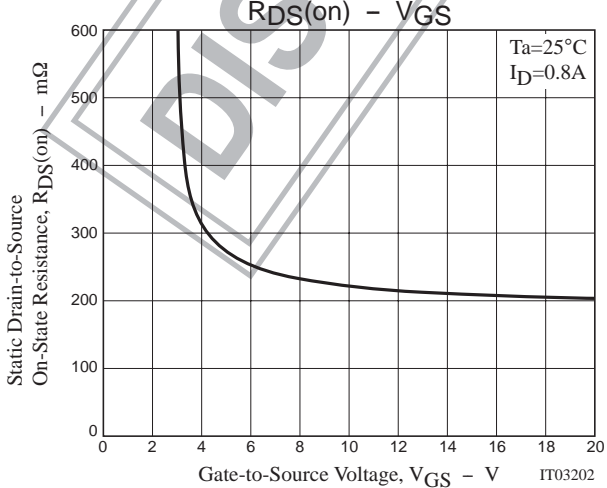
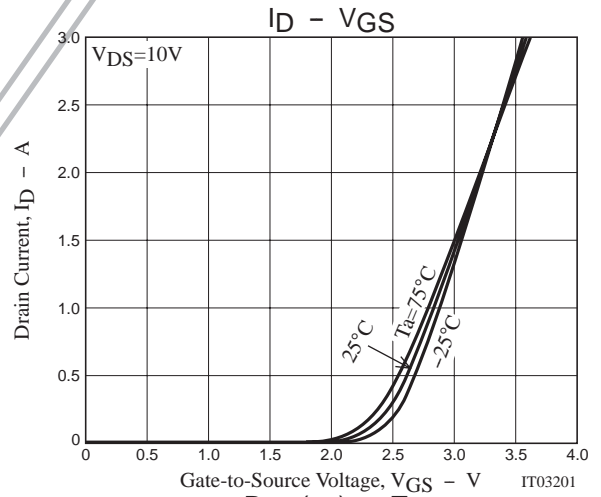
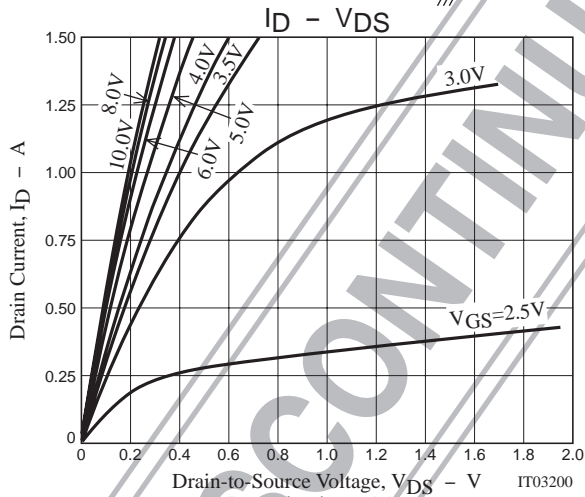
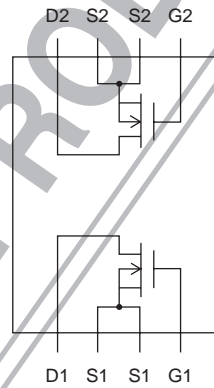
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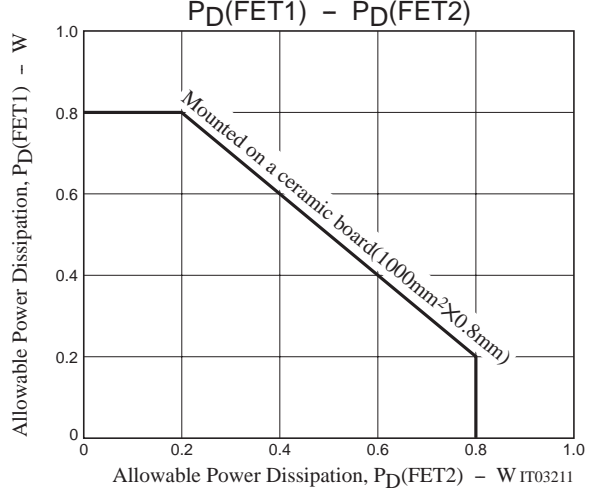
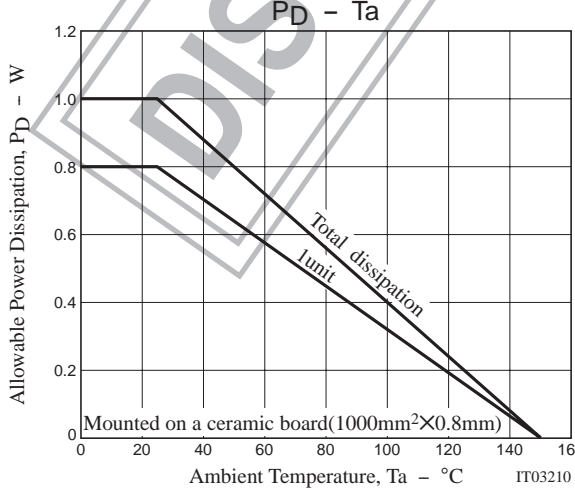
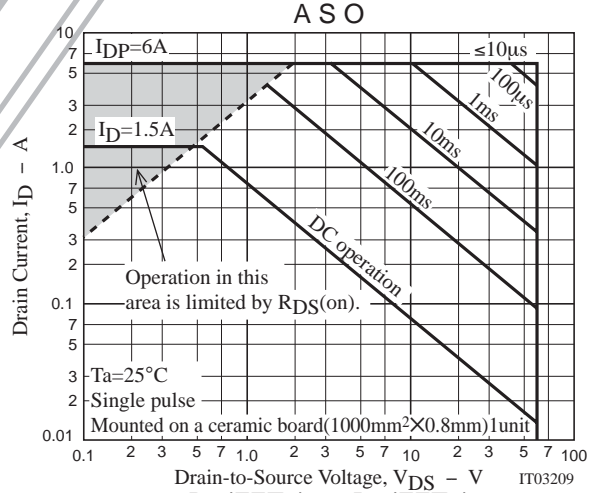
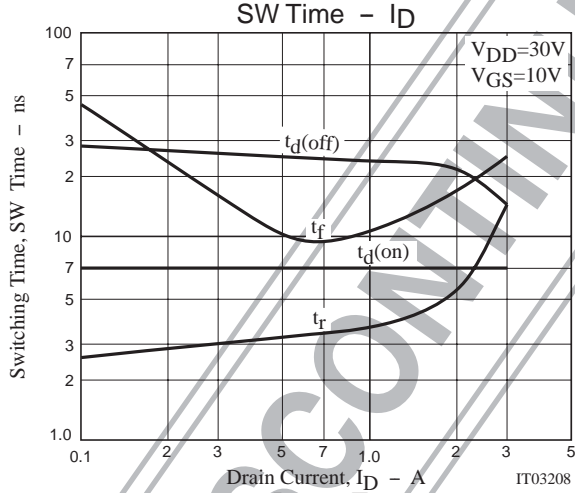
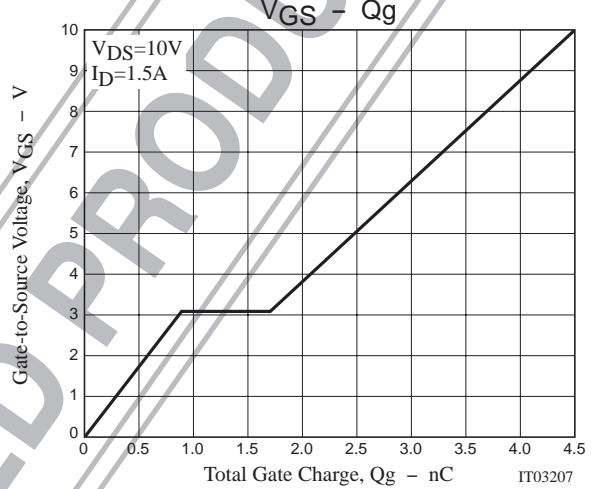
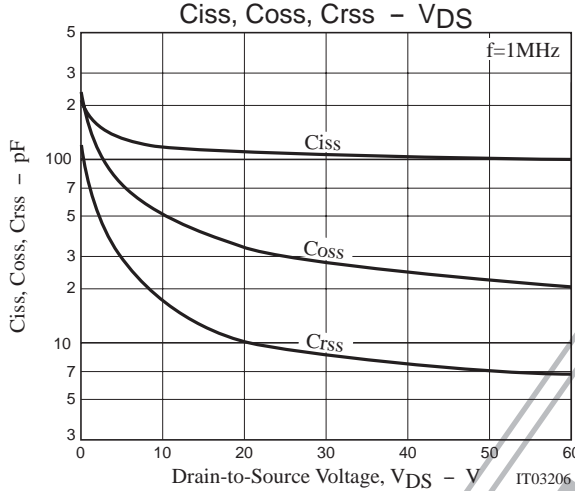
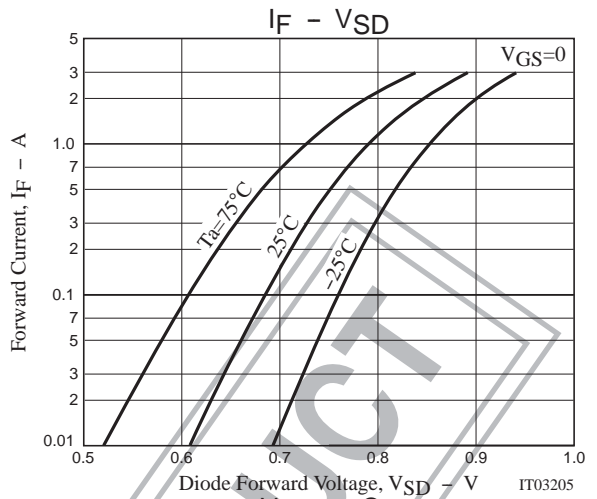
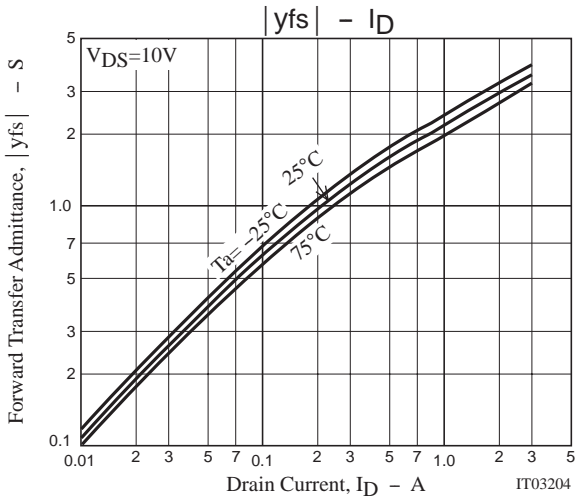
| Parameter                                  | Symbol        | Conditions                         | Ratings |      |     | Unit       |
|--|---------------|------------------------------------|---------|------|-----|------------|
|  |               |                                    | min     | typ  | max |            |
| Static Drain-to-Source On-State Resistance | $R_{DS(on)1}$ | $I_D=0.8A, V_{GS}=10V$             |         | 240  | 320 | m $\Omega$ |
|  | $R_{DS(on)2}$ | $I_D=0.8A, V_{GS}=4V$              |         | 320  | 440 | m $\Omega$ |
| Input Capacitance                          | $C_{iss}$     | $V_{DS}=20V, f=1MHz$               |         | 110  |     | pF         |
| Output Capacitance                         | $C_{oss}$     | $V_{DS}=20V, f=1MHz$               |         | 35   |     | pF         |
| Reverse Transfer Capacitance               | $C_{rss}$     | $V_{DS}=20V, f=1MHz$               |         | 10   |     | pF         |
| Turn-ON Delay Time                         | $t_d(on)$     | See specified Test Circuit         |         | 7    |     | ns         |
| Rise Time                                  | $t_r$         | See specified Test Circuit         |         | 4    |     | ns         |
| Turn-OFF Delay Time                        | $t_d(off)$    | See specified Test Circuit         |         | 24   |     | ns         |
| Fall Time                                  | $t_f$         | See specified Test Circuit         |         | 11   |     | ns         |
| Total Gate Charge                          | $Q_g$         | $V_{DS}=10V, V_{GS}=10V, I_D=1.5A$ |         | 4.5  |     | nC         |
| Gate-to-Source Charge                      | $Q_{gs}$      | $V_{DS}=10V, V_{GS}=10V, I_D=1.5A$ |         | 0.9  |     | nC         |
| Gate-to-Drain "Miller" Charge              | $Q_{gd}$      | $V_{DS}=10V, V_{GS}=10V, I_D=1.5A$ |         | 0.8  |     | nC         |
| Diode Forward Voltage                      | $V_{SD}$      | $I_S=1.5A, V_{GS}=0$               |         | 0.82 | 1.2 | V          |

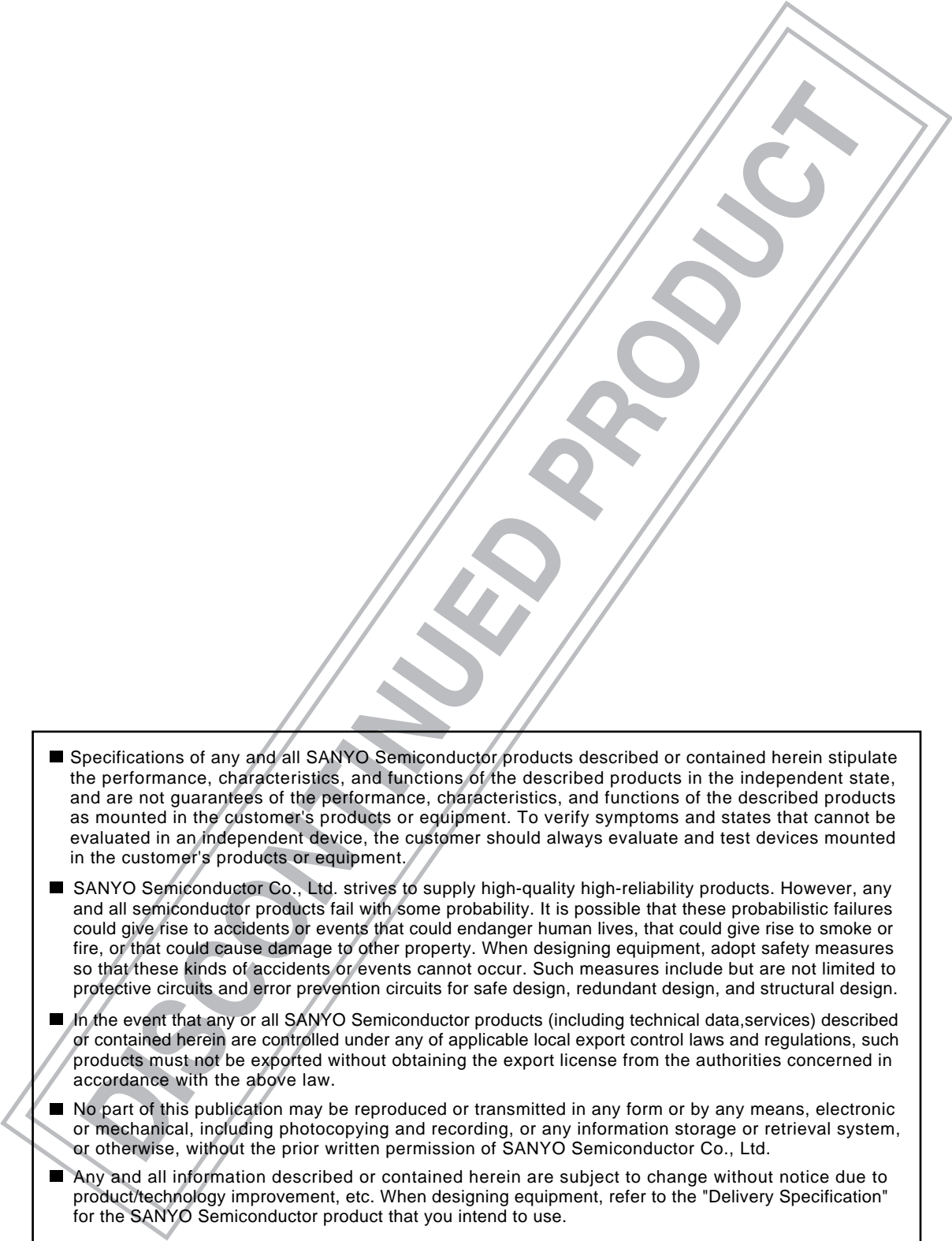
## Switching Time Test Circuit



## Electrical Connection





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